



Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



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Accreditation No.: SCS 108

Client: Auden

Certificate No: DAE4-905_Jun10

CALIBRATION CERTIFICATE

Object: DAE4 - SD 000 D04 BK - SN: 905
Calibration procedure(s): QA CAL-06.v21 Calibration procedure for the data acquisition electronics (DAE)
Calibration date: June 22, 2010

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Table with 4 columns: Standards, ID #, Date, and Scheduled. Rows include Keithley Multimeter Type 2001 and Calibrator Box V1.1.

Calibrated by: Eric Heimfeld, Technician
Approved by: Fin Bornhoff, R&D Director

Issued: June 22, 2010

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Accreditation No.: **SCS 108**

Glossary

DAE data acquisition electronics
Connector angle information used in DAS Y system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- *DC Voltage Measurement:* Calibration Factor assessed for use in DAS Y system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- *Connector angle:* The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - *DC Voltage Measurement Linearity:* Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - *Common mode sensitivity:* Influence of a positive or negative common mode voltage on the differential measurement.
 - *Channel separation:* Influence of a voltage on the neighbor channels not subject to an input voltage.
 - *AD Converter Values with inputs shorted:* Values on the internal AD converter corresponding to zero input voltage
 - *Input Offset Measurement:* Output voltage and statistical results over a large number of zero voltage measurements.
 - *Input Offset Current:* Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - *Input resistance:* DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - *Low Battery Alarm Voltage:* Typical value for information. Below this voltage, a battery alarm signal is generated.
 - *Power consumption:* Typical value for information. Supply currents in various operating modes.



DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 μ V , full range = -100...+300 mV

Low Range: 1LSB = 61nV , full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

| Calibration Factors | X | Y | Z |
|---------------------|--------------------------|--------------------------|--------------------------|
| High Range | 404.172 \pm 0.1% (k=2) | 404.719 \pm 0.1% (k=2) | 404.299 \pm 0.1% (k=2) |
| Low Range | 3.92185 \pm 0.7% (k=2) | 3.96735 \pm 0.7% (k=2) | 3.95590 \pm 0.7% (k=2) |

Connector Angle

| | |
|---|-------------------------------------|
| Connector Angle to be used in DASY system | 224.0 $^{\circ}$ \pm 1 $^{\circ}$ |
|---|-------------------------------------|



Appendix

1. DC Voltage Linearity

| High Range | Reading (μV) | Difference (μV) | Error (%) |
|-------------------|---------------------------|------------------------------|-----------|
| Channel X + Input | 200001.5 | -1.21 | -0.00 |
| Channel X + Input | 20004.18 | 4.08 | 0.02 |
| Channel X - Input | -19998.09 | 1.31 | -0.01 |
| Channel Y + Input | 199989.6 | -3.28 | -0.00 |
| Channel Y + Input | 20002.74 | 2.64 | 0.01 |
| Channel Y - Input | -20004.20 | -4.90 | 0.02 |
| Channel Z + Input | 199999.1 | -2.08 | -0.00 |
| Channel Z + Input | 20000.78 | 0.78 | 0.00 |
| Channel Z - Input | -20002.05 | -1.75 | 0.01 |

| Low Range | Reading (μV) | Difference (μV) | Error (%) |
|-------------------|---------------------------|------------------------------|-----------|
| Channel X + Input | 1999.7 | -0.25 | -0.01 |
| Channel X + Input | 199.59 | -0.21 | -0.11 |
| Channel X - Input | -200.49 | -0.59 | 0.30 |
| Channel Y + Input | 2000.0 | -0.16 | -0.01 |
| Channel Y + Input | 199.13 | -0.87 | -0.44 |
| Channel Y - Input | -201.14 | -0.94 | 0.47 |
| Channel Z + Input | 1999.6 | -0.51 | -0.03 |
| Channel Z + Input | 198.64 | -1.16 | -0.58 |
| Channel Z - Input | -201.10 | -0.80 | 0.40 |

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

| | Common mode Input Voltage (mV) | High Range Average Reading (μV) | Low Range Average Reading (μV) |
|-----------|--------------------------------|--|---|
| Channel X | 200 | 9.56 | 8.24 |
| | -200 | -6.95 | -8.74 |
| Channel Y | 200 | 7.60 | 8.28 |
| | -200 | -9.44 | -9.48 |
| Channel Z | 200 | 1.21 | 1.69 |
| | -200 | -4.02 | -3.13 |

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

| | Input Voltage (mV) | Channel X (μV) | Channel Y (μV) | Channel Z (μV) |
|-----------|--------------------|-----------------------------|-----------------------------|-----------------------------|
| Channel X | 200 | - | 0.13 | 0.14 |
| Channel Y | 200 | 1.99 | - | 1.21 |
| Channel Z | 200 | -0.08 | -2.01 | - |



4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

| | High Range (LSB) | Low Range (LSB) |
|-----------|------------------|-----------------|
| Channel X | 15895 | 15875 |
| Channel Y | 16144 | 17080 |
| Channel Z | 16372 | 15861 |

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10MΩ

| | Average (μV) | min. Offset (μV) | max. Offset (μV) | Std. Deviation (μV) |
|-----------|--------------|------------------|------------------|---------------------|
| Channel X | 0.19 | -1.12 | 1.82 | 0.29 |
| Channel Y | -0.55 | -1.09 | 0.03 | 0.21 |
| Channel Z | -1.01 | -2.14 | 0.10 | 0.39 |

6. Input Offset Current

Nominal input circuitry offset current on all channels: <25fA

7. Input Resistance

| | Zeroing (MOhm) | Measuring (MOhm) |
|-----------|----------------|------------------|
| Channel X | 0.1999 | 201.6 |
| Channel Y | 0.2000 | 199.4 |
| Channel Z | 0.2000 | 199.8 |

8. Low Battery Alarm Voltage (verified during pre test)

| Typical values | Alarm Level (VDC) |
|----------------|-------------------|
| Supply (+ Vcc) | +7.9 |
| Supply (- Vcc) | -7.6 |

9. Power Consumption (verified during pre test)

| Typical values | Switched off (mA) | Stand by (mA) | Transmitting (mA) |
|----------------|-------------------|---------------|-------------------|
| Supply (+ Vcc) | +0.0 | +6 | +14 |
| Supply (- Vcc) | -0.01 | -8 | -9 |



Calibration Certificate of DAS Y

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Client **Sporton (Auden)**

Certificate No: **ET3-1788_Sep09**

CALIBRATION CERTIFICATE

Object **ET3DV6 - SN:1788**

Calibration procedure(s) **QA CAL-01.v6, QA CAL-23.v3 and QA CAL-25.v2
Calibration procedure for dosimetric E-field probes**

Calibration date: **September 23, 2009**

Condition of the calibrated item **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

| Primary Standards | ID # | Cal Date (Certificate No.) | Scheduled Calibration |
|----------------------------|-----------------|-------------------------------|-----------------------|
| Power meter E4419B | GB41293874 | 1-Apr-09 (No. 217-01030) | Apr-10 |
| Power sensor E4412A | MY41495277 | 1-Apr-09 (No. 217-01030) | Apr-10 |
| Power sensor E4412A | MY41498087 | 1-Apr-09 (No. 217-01030) | Apr-10 |
| Reference 3 dB Attenuator | SN: S5054 (3c) | 31-Mar-09 (No. 217-01026) | Mar-10 |
| Reference 20 dB Attenuator | SN: S5086 (20b) | 31-Mar-09 (No. 217-01028) | Mar-10 |
| Reference 30 dB Attenuator | SN: S5129 (30b) | 31-Mar-09 (No. 217-01027) | Mar-10 |
| Reference Probe ES3DV2 | SN: 3013 | 2-Jan-09 (No. ES3-3013_Jan09) | Jan-10 |
| DAE4 | SN: 660 | 9-Sep-08 (No. DAE4-660_Sep08) | Sep-09 |

| Secondary Standards | ID # | Check Date (in house) | Scheduled Check |
|---------------------------|--------------|-----------------------------------|------------------------|
| RF generator HP 8648C | US3642U01700 | 4-Aug-99 (in house check Oct-07) | In house check: Oct-09 |
| Network Analyzer HP 8753E | US37390585 | 18-Oct-01 (in house check Oct-08) | In house check: Oct-09 |

| | | | |
|----------------|--------------------------------|--|---------------|
| Calibrated by: | Name Claudio Leubler | Function Laboratory Technician | Signature |
| Approved by: | Name Katja Pokovic | Technical Manager | |

Issued: September 23, 2009

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Glossary:

| | |
|--------------------------|--|
| TSL | tissue simulating liquid |
| NORM _{x,y,z} | sensitivity in free space |
| ConvF | sensitivity in TSL / NORM _{x,y,z} |
| DCP | diode compression point |
| Polarization ϕ | ϕ rotation around probe axis |
| Polarization ϑ | ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis |

Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}:** Assessed for E-field polarization $\vartheta = 0$ ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide). NORM_{x,y,z} are only intermediate values, i.e., the uncertainties of NORM_{x,y,z} does not effect the E²-field uncertainty inside TSL (see below ConvF).
- NORM(f)_{x,y,z} = NORM_{x,y,z} * frequency_response** (see Frequency Response Chart). This linearization is implemented in DAS Y4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCP_{x,y,z}:** DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- ConvF and Boundary Effect Parameters:** Assessed in flat phantom using E-field (or Temperature Transfer Standard for $f \leq 800$ MHz) and inside waveguide using analytical field distributions based on power measurements for $f > 800$ MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DAS Y4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM_{x,y,z} * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DAS Y version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- Spherical isotropy (3D deviation from isotropy):** in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset:** The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.



ET3DV6 SN:1788

September 23, 2009

Probe ET3DV6

SN:1788

| | |
|------------------|--------------------|
| Manufactured: | May 28, 2003 |
| Last calibrated: | September 23, 2008 |
| Recalibrated: | September 23, 2009 |

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)



ET3DV6 SN:1788

September 23, 2009

DASY - Parameters of Probe: ET3DV6 SN:1788

Sensitivity in Free Space^A

Diode Compression^B

| | | | | |
|-------|--------------|-----------------------|-------|-------|
| NormX | 1.79 ± 10.1% | μV/(V/m) ² | DCP X | 95 mV |
| NormY | 1.68 ± 10.1% | μV/(V/m) ² | DCP Y | 98 mV |
| NormZ | 1.74 ± 10.1% | μV/(V/m) ² | DCP Z | 91 mV |

Sensitivity in Tissue Simulating Liquid (Conversion Factors)

Please see Page 8.

Boundary Effect

TSL 835 MHz Typical SAR gradient: 5 % per mm

| | | | |
|---|------------------------------|--------|--------|
| Sensor Center to Phantom Surface Distance | | 3.7 mm | 4.7 mm |
| SAR _{be} [%] | Without Correction Algorithm | 10.4 | 6.8 |
| SAR _{be} [%] | With Correction Algorithm | 0.8 | 0.5 |

TSL 1750 MHz Typical SAR gradient: 10 % per mm

| | | | |
|---|------------------------------|--------|--------|
| Sensor Center to Phantom Surface Distance | | 3.7 mm | 4.7 mm |
| SAR _{be} [%] | Without Correction Algorithm | 12.5 | 8.3 |
| SAR _{be} [%] | With Correction Algorithm | 0.8 | 0.4 |

Sensor Offset

Probe Tip to Sensor Center 2.7 mm

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^A The uncertainties of NormX,Y,Z do not affect the E²-field uncertainty inside TSL (see Page 8).

^B Numerical linearization parameter: uncertainty not required.

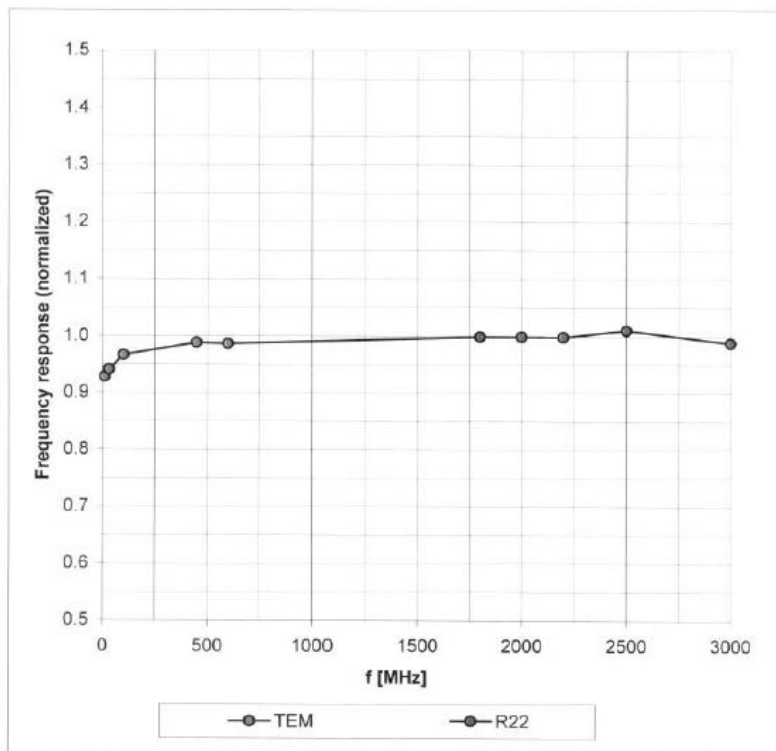


ET3DV6 SN:1788

September 23, 2009

Frequency Response of E-Field

(TEM-Cell:ifi110 EXX, Waveguide: R22)



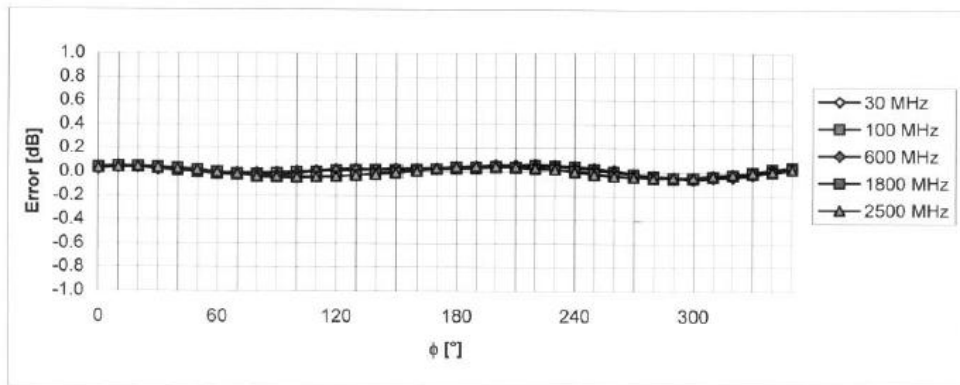
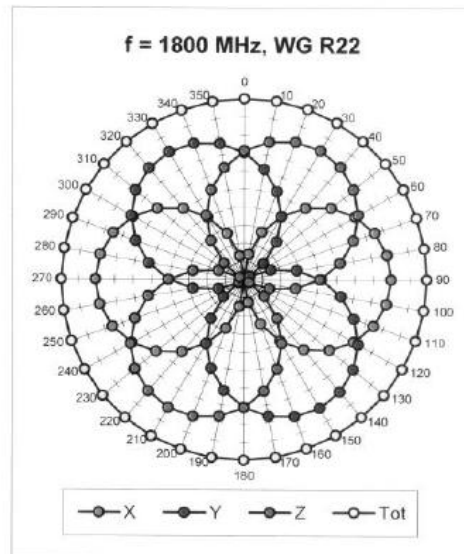
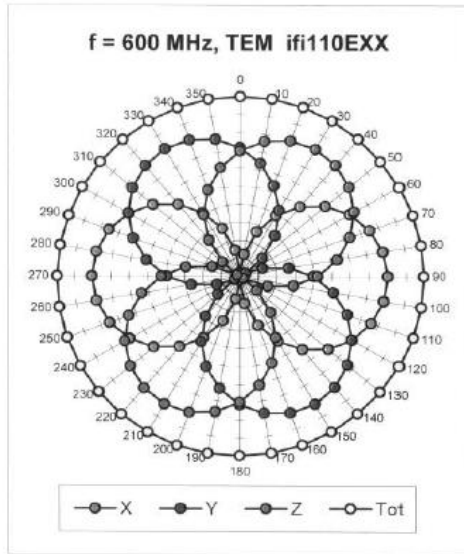
Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ ($k=2$)



ET3DV6 SN:1788

September 23, 2009

Receiving Pattern (ϕ), $\theta = 0^\circ$



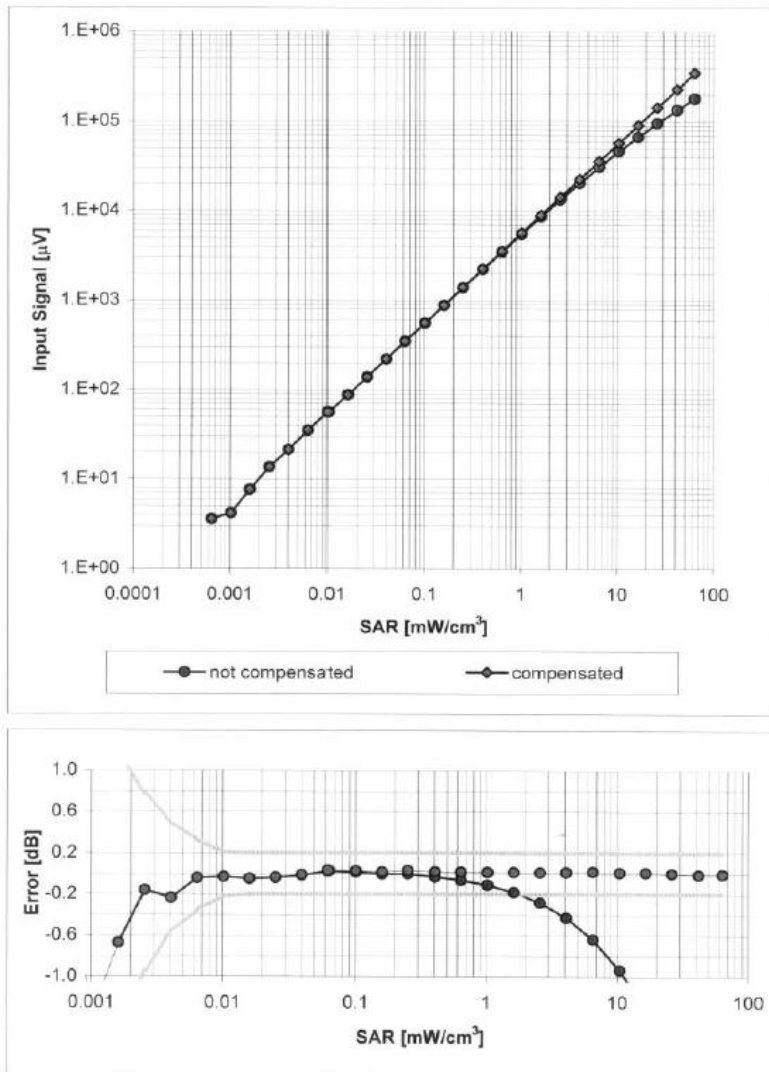
Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ (k=2)



ET3DV6 SN:1788

September 23, 2009

Dynamic Range $f(\text{SAR}_{\text{head}})$ (Waveguide R22, $f = 1800 \text{ MHz}$)

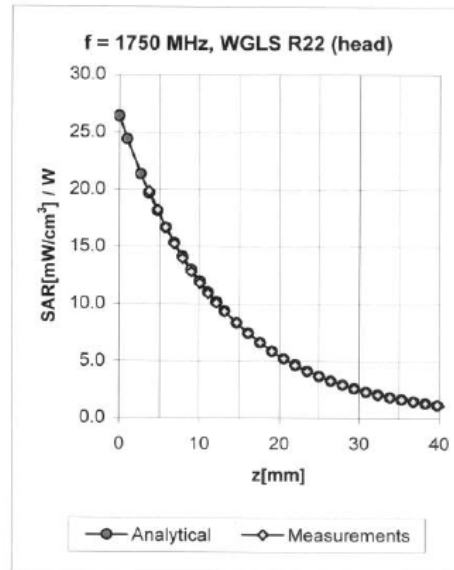
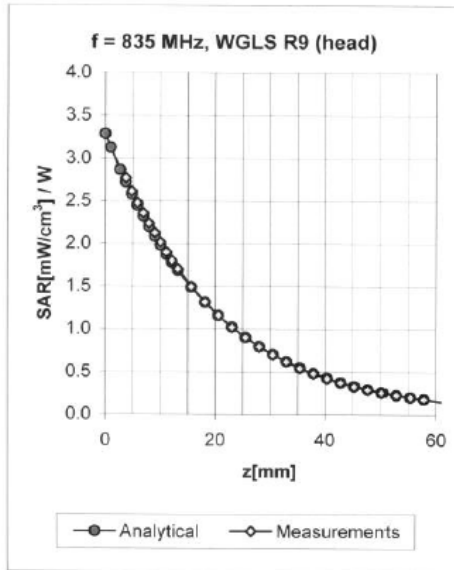


Uncertainty of Linearity Assessment: $\pm 0.6\%$ ($k=2$)

ET3DV6 SN:1788

September 23, 2009

Conversion Factor Assessment



| f [MHz] | Validity [MHz] ^c | TSL | Permittivity | Conductivity | Alpha | Depth | ConvF Uncertainty |
|---------|-----------------------------|------|--------------|--------------|-------|-------|--------------------|
| 835 | ± 50 / ± 100 | Head | 41.5 ± 5% | 0.90 ± 5% | 0.35 | 2.50 | 6.30 ± 11.0% (k=2) |
| 1750 | ± 50 / ± 100 | Head | 40.1 ± 5% | 1.37 ± 5% | 0.50 | 2.63 | 5.40 ± 11.0% (k=2) |
| 1900 | ± 50 / ± 100 | Head | 40.0 ± 5% | 1.40 ± 5% | 0.68 | 2.24 | 5.11 ± 11.0% (k=2) |
| 2450 | ± 50 / ± 100 | Head | 39.2 ± 5% | 1.80 ± 5% | 0.99 | 1.77 | 4.48 ± 11.0% (k=2) |
| 835 | ± 50 / ± 100 | Body | 55.2 ± 5% | 0.97 ± 5% | 0.33 | 2.65 | 6.08 ± 11.0% (k=2) |
| 1750 | ± 50 / ± 100 | Body | 53.4 ± 5% | 1.49 ± 5% | 0.58 | 3.48 | 4.77 ± 11.0% (k=2) |
| 1900 | ± 50 / ± 100 | Body | 53.3 ± 5% | 1.52 ± 5% | 0.75 | 2.85 | 4.52 ± 11.0% (k=2) |
| 2450 | ± 50 / ± 100 | Body | 52.7 ± 5% | 1.95 ± 5% | 0.99 | 1.54 | 4.19 ± 11.0% (k=2) |

^c The validity of ± 100 MHz only applies for DASYS v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

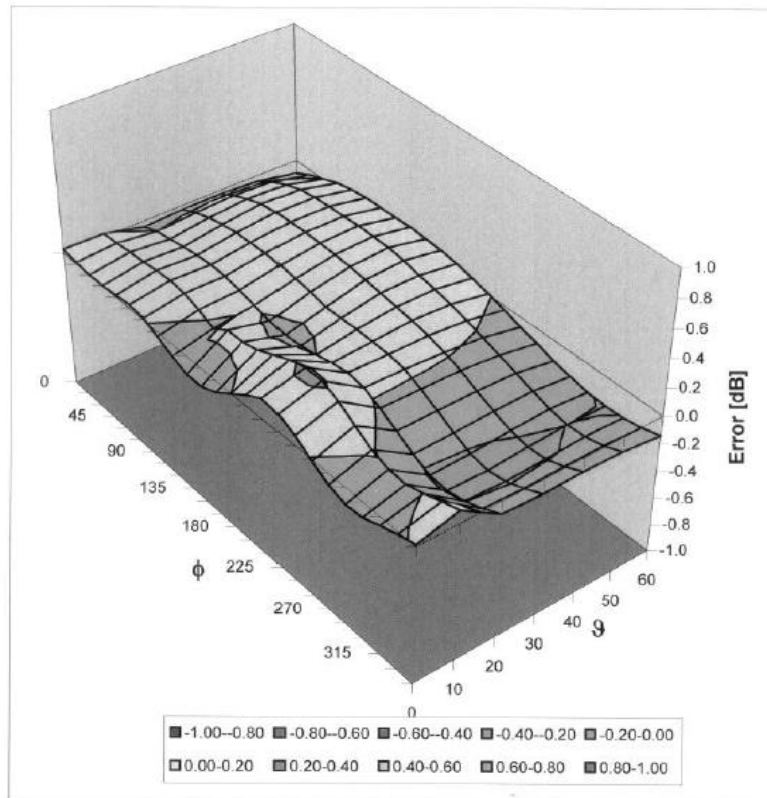


ET3DV6 SN:1788

September 23, 2009

Deviation from Isotropy in HSL

Error (ϕ , θ), $f = 900$ MHz



Uncertainty of Spherical Isotropy Assessment: $\pm 2.6\%$ ($k=2$)



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Accreditation No.: SCS 108

Client Sporton (Auden)

Certificate No: ET3-1788_Sep10

CALIBRATION CERTIFICATE

Object: ET3DV6 - SN:1788
Calibration procedure(s): QA CAL-01.v6, QA CAL-23.v3 and QA CAL-25.v2
Calibration procedure for dosimetric E-field probes
Calibration date: September 21, 2010

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Table with 4 columns: Primary Standards, ID #, Cal Date (Certificate No.), Scheduled Calibration. Lists equipment like Power meter E4419B, Power sensor E4412A, Reference 3 dB Attenuator, etc.

Table with 4 columns: Secondary Standards, ID #, Check Date (in house), Scheduled Check. Lists RF generator HP 8648C, Network Analyzer HP 8753E.

Calibrated by: Jeton Kastrati, Laboratory Technician
Approved by: Katja Pokovic, Technical Manager

Issued: September 22, 2010

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Accreditation No.: SCS 108

Glossary:

Table with 2 columns: Term and Definition. Terms include TSL, NORMx,y,z, ConvF, DCP, CF, A, B, C, Polarization phi, Polarization theta.

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

Methods Applied and Interpretation of Parameters:

- NORMx,y,z: Assessed for E-field polarization theta = 0 (f <= 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide). NORMx,y,z are only intermediate values, i.e., the uncertainties of NORMx,y,z does not effect the E^2-field uncertainty inside TSL (see below ConvF).
NORM(f)x,y,z = NORMx,y,z * frequency_response (see Frequency Response Chart). This linearization is implemented in DASy4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
Ax,y,z; Bx,y,z; Cx,y,z, VRx,y,z: A, B, C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
ConvF and Boundary Effect Parameters: Assessed in flat phantom using E-field (or Temperature Transfer Standard for f <= 800 MHz) and inside waveguide using analytical field distributions based on power measurements for f > 800 MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASy4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORMx,y,z * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASy version 4.4 and higher which allows extending the validity from +/- 50 MHz to +/- 100 MHz.
Spherical isotropy (3D deviation from isotropy): in a field of low gradients realized using a flat phantom exposed by a patch antenna.
Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.



ET3DV6 SN:1788

September 21, 2010

Probe ET3DV6

SN:1788

| | |
|------------------|--------------------|
| Manufactured: | May 28, 2003 |
| Last calibrated: | September 23, 2009 |
| Recalibrated: | September 21, 2010 |

Calibrated for DASy/EASy Systems

(Note: non-compatible with DASy2 system!)



ET3DV6 SN:1788

September 21, 2010

DASY/EASY - Parameters of Probe: ET3DV6 SN:1788

Basic Calibration Parameters

| | Sensor X | Sensor Y | Sensor Z | Unc (k=2) |
|---|----------|----------|----------|--------------|
| Norm ($\mu\text{V}/(\text{V}/\text{m})^2$) ^A | 1.76 | 1.69 | 1.76 | $\pm 10.1\%$ |
| DCP (mV) ^B | 91.6 | 91.0 | 95.1 | |

Modulation Calibration Parameters

| UID | Communication System Name | PAR | | A dB | B dBuV | C | VR mV | Unc ^E (k=2) |
|-------|---------------------------|------|---|---------|-----------|------|----------|---------------------------|
| 10000 | CW | 0.00 | X | 0.00 | 0.00 | 1.00 | 300.0 | $\pm 1.5\%$ |
| | | | Y | 0.00 | 0.00 | 1.00 | 300.0 | |
| | | | Z | 0.00 | 0.00 | 1.00 | 300.0 | |

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^A The uncertainties of NormX,Y,Z do not affect the E²-field uncertainty inside TSL, (see Pages 5 and 6).

^B Numerical linearization parameter: uncertainty not required.

^E Uncertainty is determined using the maximum deviation from linear response applying rectangular distribution and is expressed for the square of the field value.



ET3DV6 SN:1788

September 21, 2010

DASY/EASY - Parameters of Probe: ET3DV6 SN:1788

Calibration Parameter Determined in Head Tissue Simulating Media

| f [MHz] | Validity [MHz] ^c | Permittivity | Conductivity | ConvF X | ConvF Y | ConvF Z | Alpha | Depth Unc (k=2) |
|---------|-----------------------------|--------------|--------------|---------|---------|---------|-------|-----------------|
| 835 | ± 50 / ± 100 | 41.5 ± 5% | 0.90 ± 5% | 6.23 | 6.23 | 6.23 | 0.41 | 2.32 ± 11.0% |
| 900 | ± 50 / ± 100 | 41.5 ± 5% | 0.97 ± 5% | 6.11 | 6.11 | 6.11 | 0.29 | 2.85 ± 11.0% |
| 1750 | ± 50 / ± 100 | 40.1 ± 5% | 1.37 ± 5% | 5.29 | 5.29 | 5.29 | 0.51 | 2.51 ± 11.0% |
| 1900 | ± 50 / ± 100 | 40.0 ± 5% | 1.40 ± 5% | 5.03 | 5.03 | 5.03 | 0.66 | 2.25 ± 11.0% |
| 2450 | ± 50 / ± 100 | 39.2 ± 5% | 1.80 ± 5% | 4.35 | 4.35 | 4.35 | 0.99 | 1.69 ± 11.0% |

^c The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.



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DASY/EASY - Parameters of Probe: ET3DV6 SN:1788

Calibration Parameter Determined in Body Tissue Simulating Media

| f [MHz] | Validity [MHz] ^c | Permittivity | Conductivity | ConvF X | ConvF Y | ConvF Z | Alpha | Depth Unc (k=2) |
|---------|-----------------------------|--------------|--------------|---------|---------|---------|-------|-----------------|
| 835 | ± 50 / ± 100 | 55.2 ± 5% | 0.97 ± 5% | 5.99 | 5.99 | 5.99 | 0.35 | 2.62 ± 11.0% |
| 900 | ± 50 / ± 100 | 55.0 ± 5% | 1.05 ± 5% | 6.07 | 6.07 | 6.07 | 0.32 | 2.87 ± 11.0% |
| 1750 | ± 50 / ± 100 | 53.4 ± 5% | 1.49 ± 5% | 4.67 | 4.67 | 4.67 | 0.61 | 3.09 ± 11.0% |
| 1900 | ± 50 / ± 100 | 53.3 ± 5% | 1.52 ± 5% | 4.39 | 4.39 | 4.39 | 0.83 | 2.56 ± 11.0% |
| 2450 | ± 50 / ± 100 | 52.7 ± 5% | 1.95 ± 5% | 4.04 | 4.04 | 4.04 | 0.99 | 1.40 ± 11.0% |

^c The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

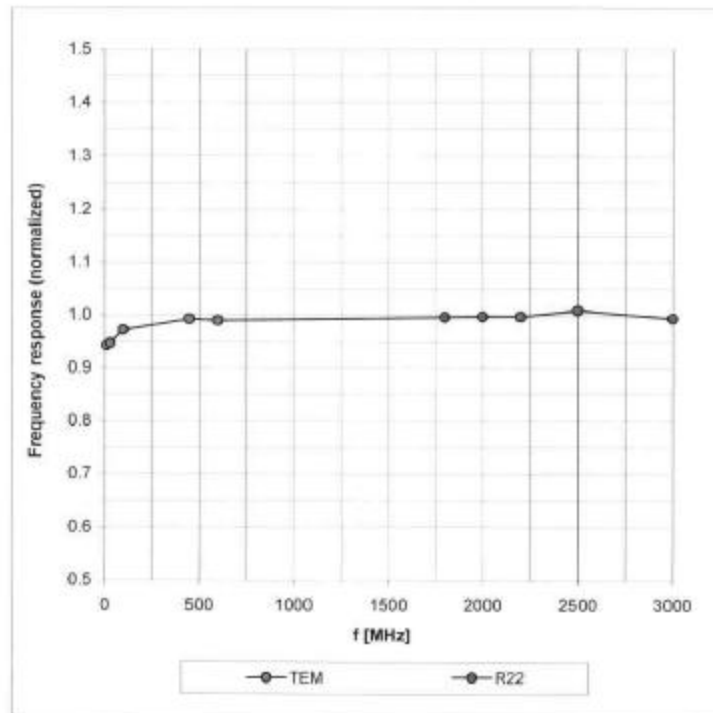


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Frequency Response of E-Field

(TEM-Cell:ifi110 EXX, Waveguide: R22)



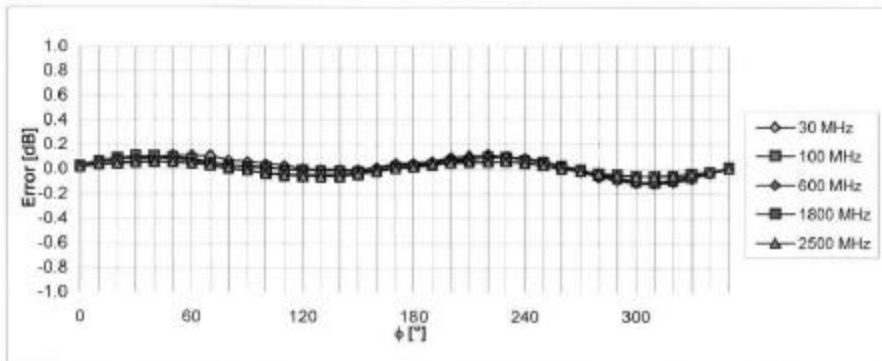
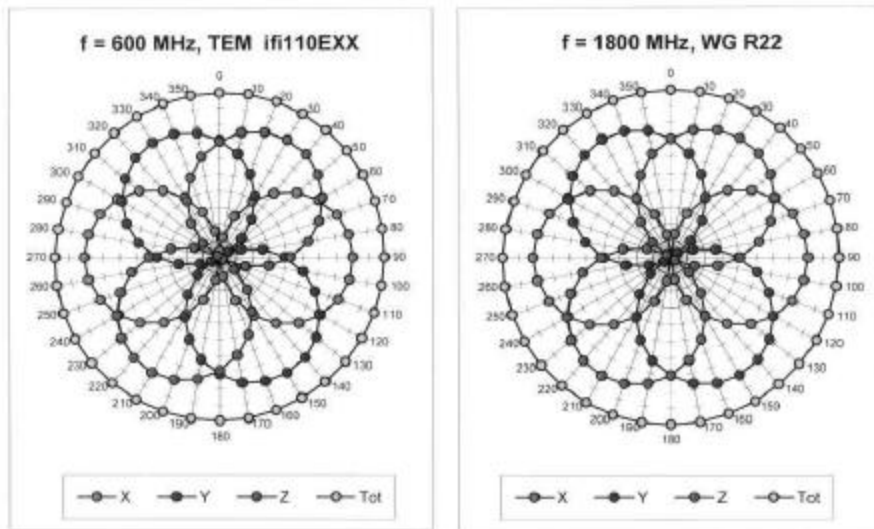
Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ (k=2)



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Receiving Pattern (ϕ), $\theta = 0^\circ$



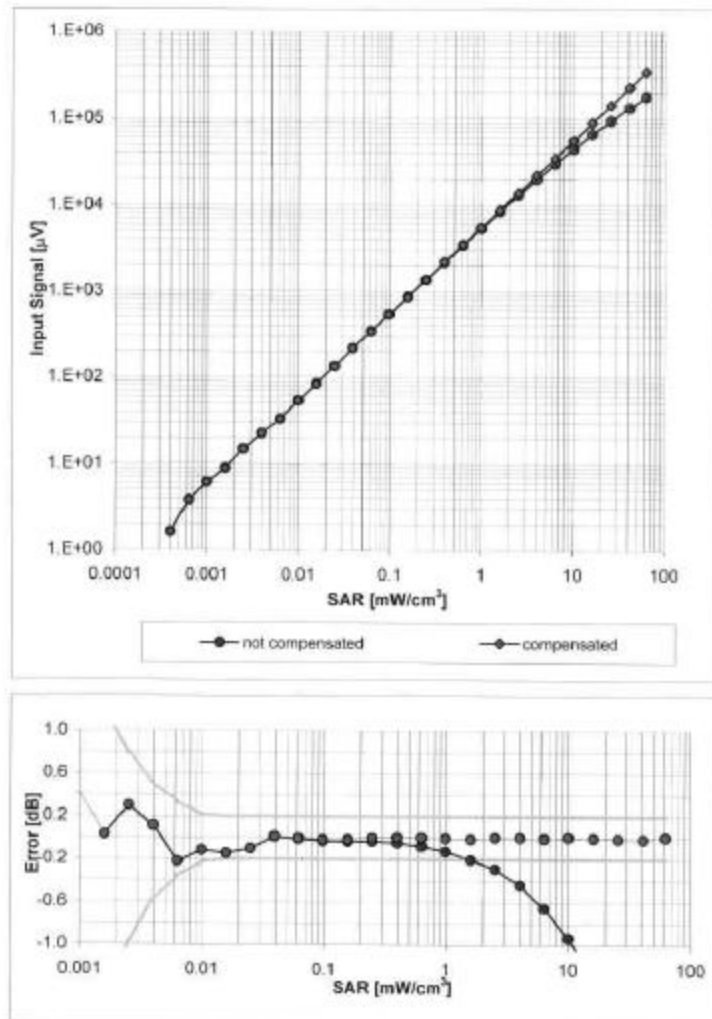
Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ (k=2)



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Dynamic Range f(SAR_{head}) (Waveguide R22, f = 1800 MHz)

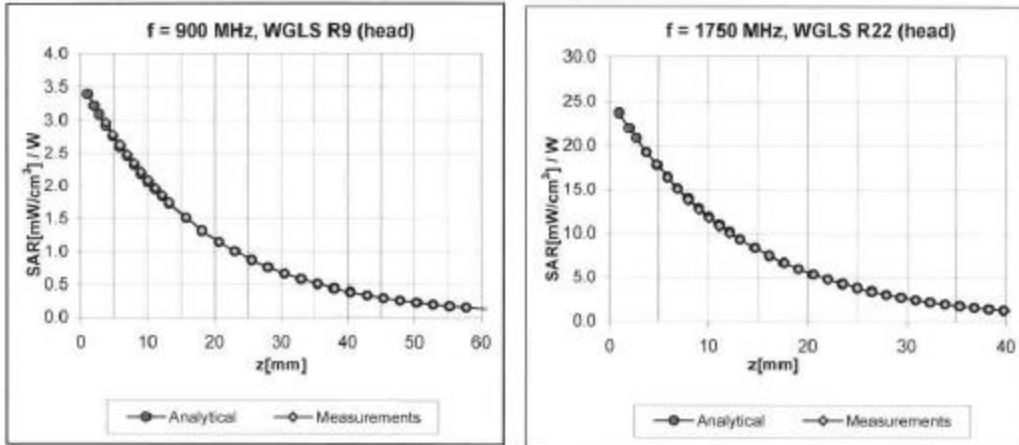


Uncertainty of Linearity Assessment: ± 0.6% (k=2)

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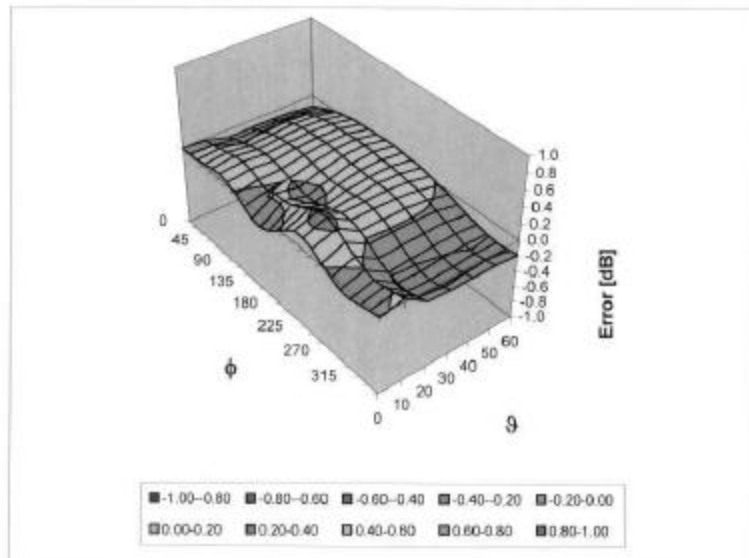
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Conversion Factor Assessment



Deviation from Isotropy in HSL

Error (ϕ, θ), f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: $\pm 2.6\%$ (k=2)



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Other Probe Parameters

| | |
|---|----------------|
| Sensor Arrangement | Triangular |
| Connector Angle (°) | Not applicable |
| Mechanical Surface Detection Mode | enabled |
| Optical Surface Detection Mode | disabled |
| Probe Overall Length | 337 mm |
| Probe Body Diameter | 10 mm |
| Tip Length | 10 mm |
| Tip Diameter | 6.8 mm |
| Probe Tip to Sensor X Calibration Point | 2.7 mm |
| Probe Tip to Sensor Y Calibration Point | 2.7 mm |
| Probe Tip to Sensor Z Calibration Point | 2.7 mm |
| Recommended Measurement Distance from Surface | 4 mm |